

SIPMOS® Small-Signal-Transistor

Features

- N-channel
- Depletion mode
- dv/dt rated
- \bullet Available with $V_{\rm GS(th)}$ indicator on reel
- Qualified according to AEC Q101
- 100% lead-free; Halogen-free; RoHS compliant

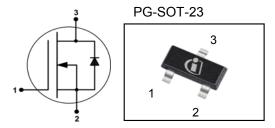






Product Summary

V_{DS}	60	V
$R_{\mathrm{DS(on)},\mathrm{max}}$	8	Ω
I _{DSS,min}	0.13	Α



Туре	Package	Pb-free	Halogen-free	Tape and Reel Information	Marking
BSS159N	PG-SOT-23	Yes	Yes	H6327: 3000 pcs/reel	SGs
BSS159N	PG-SOT-23	Yes	Yes	H6906: 3000 pcs/reel sorted in $V_{\rm GS(th)}$ bands ¹⁾	SGs

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T _A =25 °C	0.23	А
		T _A =70 °C	0.18	
Pulsed drain current	I _{D,pulse}	T _A =25 °C	0.92	
Reverse diode d v /d t	dv/dt	$I_{\rm D}$ =0.23 A, $V_{\rm DS}$ =60 V, di/dt=200 A/ μ s, $T_{\rm j,max}$ =150 °C	6	kV/μs
Gate source voltage	V_{GS}		±20	V
ESD Class		JESD22-A114 -HBM	0(<250V)	
Power dissipation	P_{tot}	T _A =25 °C	0.36	W
Operating and storage temperature	$T_{\rm j},~T_{\rm stg}$		-55 150	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

¹⁾ see table on next page and diagram 11



Μ

Ν

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	1
Thermal characteristics						
Thermal characteristics	R_{thJA}	minimal footprint	-	-	350	K/W
Electrical characteristics, at T_j =29	5 °C, unless	otherwise specified				
Static characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =-10 V, I _D =250 μA	60	-	-	V
Gate threshold voltage	V _{GS(th)}	V _{DS} =3 V, I _D =26 μA	-3.5	-2.8	-2.4	
Drain-source cutoff current	I _{D(off)}	V _{DS} =60 V, V _{GS} =-10 V, T _j =25 °C	-	-	0.1	μΑ
		V _{DS} =60 V, V _{GS} =-10 V, T _j =125 °C	-	-	10	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	10	nA
On-state drain current	I _{DSS}	V _{GS} =0 V, V _{DS} =10 V	130	-	-	mA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =0 V, I _D =0.07 A	-	3.9	8	Ω
		V _{GS} =10 V, I _D =0.16 A	-	1.7	3.5	
Transconductance	$g_{ ext{fs}}$	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 0.16~{\rm A}$	0.1	0.19	-	s
Threshold voltage V _{GS(th)} sorted i	n bands ²⁾					•
J	$V_{\rm GS(th)}$	V _{DS} =3 V, I _D =26 μA	-2.6	-	-2.4	V
K			-2.75	-	-2.55	
L			-2.9	-	-2.7	
		1				7

-3.05

-3.2

-2.85

-3

²⁾ Each reel contains transistors out of one band whose identifying letter is printed on the reel label. A specific band cannot be ordered separately.



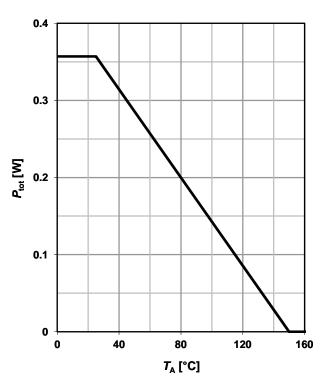
Parameter	Symbol	Symbol Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	29	39	pF
Output capacitance	Coss	V _{GS} =-3 V, V _{DS} =25 V, f=1 MHz	-	7.4	10	
Reverse transfer capacitance	C _{rss}		-	3.1	5	
Turn-on delay time	t _{d(on)}	$V_{\rm DD}$ =25 V, - $V_{\rm GS}$ =-37 V, $I_{\rm D}$ =0.16 A, $R_{\rm G}$ =6 Ω	-	3.1	4.7	ns
Rise time	t _r		-	2.9	4.4	
Turn-off delay time	$t_{d(off)}$		-	9	13	
Fall time	t _f]	-	9	13	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	0.22	-	nC
Gate to drain charge	Q_{gd}	$V_{\rm DD}$ =48 V, $I_{\rm D}$ =0.16 A, $V_{\rm GS}$ =-3 to 5 V	-	0.42	-	
Gate charge total	Q_g		-	1.4	-	
Gate plateau voltage	V _{plateau}		-	-0.80	-	V
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	0.20	А
Diode pulse current	I _{S,pulse}		-	-	0.91	
Diode forward voltage	V _{SD}	V _{GS} =-3 V, I _F =0.16 A, T _j =25 °C	-	0.81	1.2	V
Reverse recovery time	t _{rr}	V _R =30 V, I _F =0.16 A,	-	10.4	13	ns
Reverse recovery charge	Q _{rr}	$di_F/dt=100 \text{ A/}\mu\text{s}$	_	3.3	4.1	nC

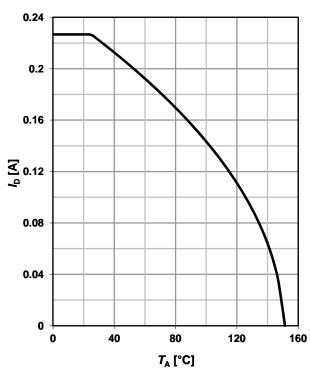


1 Power dissipation

$P_{\text{tot}} = f(T_A)$

2 Drain current





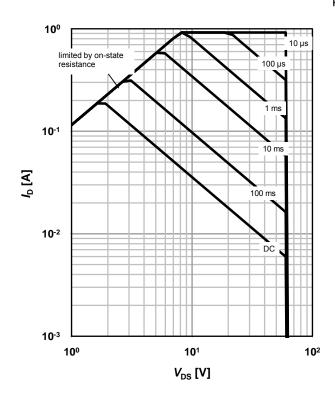
3 Safe operating area

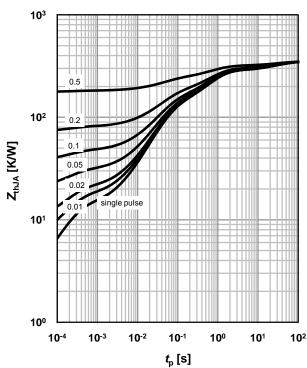
$$I_{D} = f(V_{DS}); T_{A} = 25 \text{ °C}; D = 0$$

4 Max. transient thermal impedance

$$Z_{\text{thJA}}$$
=f(t_{p})

parameter: $D=t_p/T$



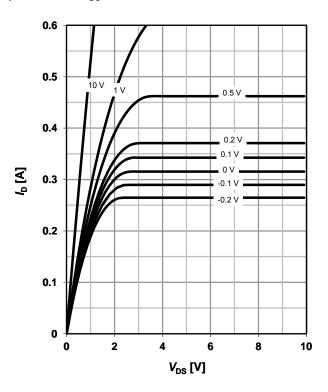




5 Typ. output characteristics

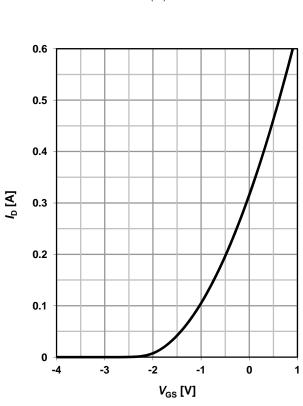
 $I_D = f(V_{DS}); T_j = 25 °C$

parameter: $V_{\rm GS}$



7 Typ. transfer characteristics

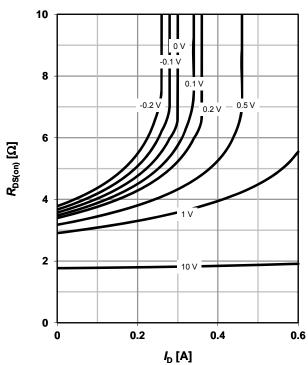
 $I_{\mathrm{D}} = f(V_{\mathrm{GS}}); |V_{\mathrm{DS}}| > 2|I_{\mathrm{D}}|R_{\mathrm{DS(on)max}}$



6 Typ. drain-source on resistance

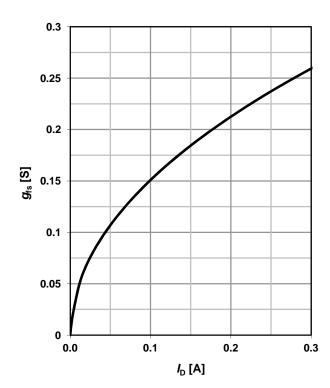
 $R_{DS(on)}$ =f(I_D); T_j =25 °C

parameter: $V_{\rm GS}$



8 Typ. forward transconductance

 g_{fs} =f(I_D); T_j =25 °C





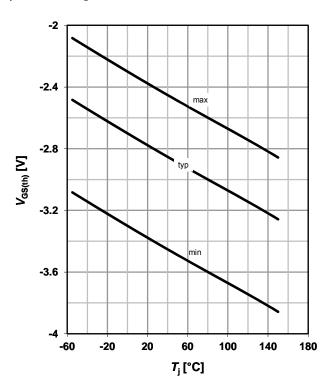
9 Drain-source on-state resistance

 $R_{DS(on)} = f(T_i); I_D = 0.07 A; V_{GS} = 0 V$

20 16 12 12 98 % 98 % 98 % 190 190 140 180 7_j [°C]

10 Typ. gate threshold voltage

 $V_{\rm GS(th)}$ =f($T_{\rm j}$); $V_{\rm DS}$ =3 V; $I_{\rm D}$ =26 $\mu{\rm A}$ parameter: $I_{\rm D}$

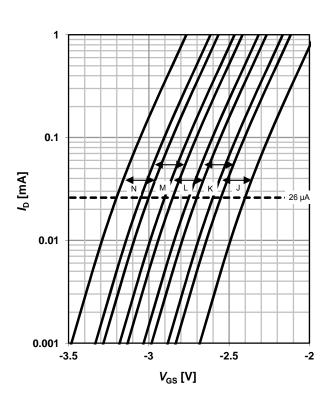


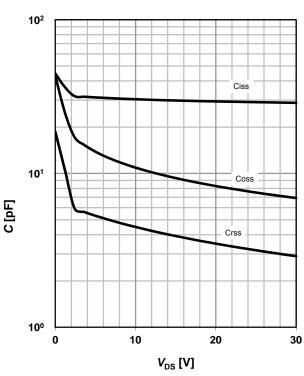
11 Threshold voltage bands

 I_D =f(V_{GS}); V_{DS} =3 V; T_j =25 °C

12 Typ. capacitances

 $C=f(V_{DS}); V_{GS}=-3 V; f=1 MHz$



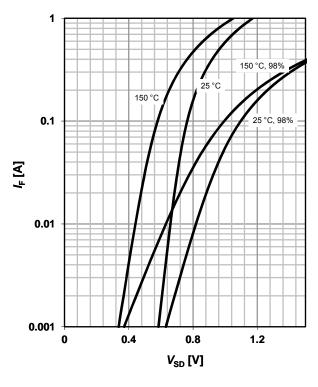




13 Forward characteristics of reverse diode

 $I_{F}=f(V_{SD})$

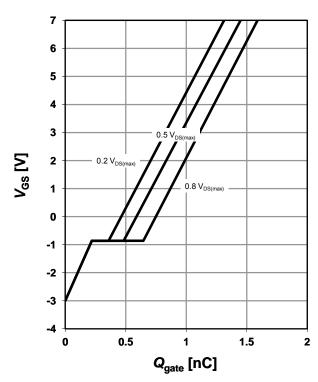
parameter: T_j



14 Typ. gate charge

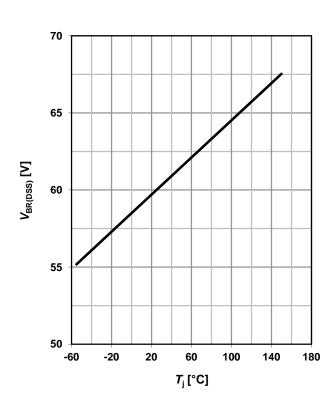
 V_{GS} =f(Q_{gate}); I_D =0.16 A pulsed

parameter: $V_{\rm DD}$

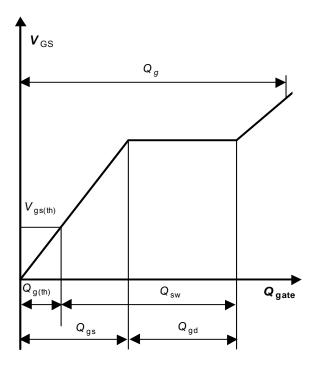


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_j); I_D =250 μ A



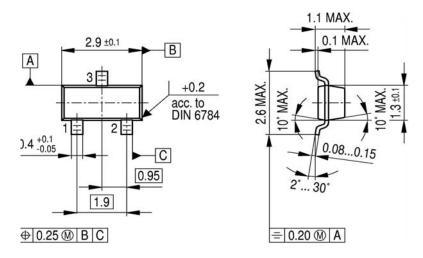
16 Gate charge waveforms





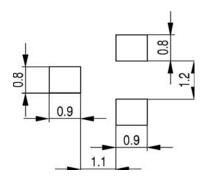
SOT-23

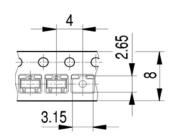
Package Outline:



Footprint:

Packaging:







Dimensions in mm



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